

Notice of References Cited	Application/Control No. 10/069,024	Applicant(s)/Patent Under Reexamination CHINO ET AL.	
	Examiner Van Kim T. Nguyen	Art Unit 2151	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6,874,018	03-2005	Wu, Handong	709/219
	B	US-6,725,460	04-2004	Nishiyama et al.	725/32
	C	US-6,629,136	09-2003	Naidoo, Surendra N.	709/219
	D	US-6,434,562	08-2002	Pennywitt et al.	707/10
	E	US-6,430,605	08-2002	Hunter, Charles Eric	709/207
	F	US-6,424,998	07-2002	Hunter, Charles Eric	709/207
	G	US-6,351,745	02-2002	Itakura et al.	707/10
	H	US-6,332,127	12-2001	Bandera et al.	705/14
	I	US-6,047,310	04-2000	Kamakura et al.	709/227
	J	US-6,014,689	01-2000	Budge et al.	709/206
	K	US-5,912,697	06-1999	Hashimoto et al.	725/114
	L	US-5,768,614	06-1998	Takagi et al.	710/1
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.